| | Application No. | Applicant(s) | |
|---|---|---|-------------------|
| | 10/786,443 | CATHEY ET AL. | |
| Notice of Allowability | Examiner | Art Unit | |
| | OTEDUEN VAM | 0070 | |
| | STEPHEN YAM | 2878 | |
| The MAILING DATE of this communication appeal claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313 | (OR REMAINS) CLOSED in or other appropriate communication is significant or other application is significant or other application is significant or other application in the significant or other applications. | n this application. If not included unication will be mailed in due cou | ırse. THIS |
| 1. X This communication is responsive to after-final amendmen | nt filed 1/21/2009 and intervi | ew with applicant conducted 1/29/ | <u>′2009</u> . |
| 2. The allowed claim(s) is/are <u>1-4,6-16,18-30 and 41-49</u> . | | | |
| Acknowledgment is made of a claim for foreign priority under a) ☐ All b) ☐ Some* c) ☐ None of the: | nder 35 U.S.C. § 119(a)-(d) | or (f). | |
| Certified copies of the priority documents have | e been received. | | |
| Certified copies of the priority documents have | e been received in Application | on No | |
| 3. \square Copies of the certified copies of the priority do | cuments have been receive | d in this national stage applicatior | ı from the |
| International Bureau (PCT Rule 17.2(a)). | | | |
| * Certified copies not received: | | | |
| Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. | | e a reply complying with the requir | ements |
| 4. A SUBSTITUTE OATH OR DECLARATION must be subminFORMAL PATENT APPLICATION (PTO-152) which give | | | ICE OF |
| 5. CORRECTED DRAWINGS (as "replacement sheets") mus | st be submitted. | | |
| (a) ☐ including changes required by the Notice of Draftspers | | w (PTO-948) attached | |
| 1) ☐ hereto or 2) ☐ to Paper No./Mail Date | - | , | |
| (b) ☐ including changes required by the attached Examiner' | • | r in the Office action of | |
| Paper No./Mail Date | | | |
| Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t | | | ck) of |
| 6. DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT | | | e the |
| | | | |
| Attachment(s) 1. ☐ Notice of References Cited (PTO-892) | 5 🗆 Notice of In | formal Patent Application | |
| | | • • | |
| 2. Notice of Draftperson's Patent Drawing Review (PTO-948) | Paper No. | ummary (PTO-413), /Mail Date | |
| 3. Information Disclosure Statements (PTO/SB/08), | 7. 🛛 Examiner's | Amendment/Comment | |
| Paper No./Mail Date 3/17/2008 4. Examiner's Comment Regarding Requirement for Deposit | 8. 🛛 Examiner's | Statement of Reasons for Allowa | nce |
| of Biological Material | 9. 🔲 Other | | |
| /Stephen Yam/ | | | |
| Primary Examiner, Art Unit 2878 | | | |
| | | | |

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EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or

additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR

1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the

payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with

John Lindemann on January 30, 2009.

The application has been amended as follows:

Cancel Claims 32-40.

Enter new Claims 41-49 as follows:

41. A non-linear optical system for imaging an object comprising:

optics for focusing and encoding a wavefront from the object to an intermediate image

such that an optical transfer function of the optical system, at the intermediate image, is more

invariant to focus-related aberrations as compared to an intermediate image formed by the optics

without encoding;

a non-linear detector for detecting the intermediate image; and

a linearization processor for linearizing the intermediate image to form a linearized

image, by measuring an exposure curve within an image detected by the nonlinear detector and

by converting the exposure curve into a substantially linear exposure curve.

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- 42. The optical system of claim 41, wherein the optics comprise a phase mask that modifies the optical transfer function of the optical system by affecting phase of the wavefronts transmitted by the phase mask.
- 43. The system of claim 41, wherein the aberrations include one or more of misfocus, spherical aberration, astigmatism, field curvature, chromatic aberration, temperature induced misfocus aberration, and pressure induced misfocus aberration.
- 44. A system of claim 41, further comprising a post processor for filtering the linearized image by removing effects of wavefront coding therefrom to form a final image.
- 45. The system of claim 41, the exposure curve comprising an overexposed region and an underexposed region, wherein any part of an image falling into the underexposed region or the overexposed region is not recorded by the detector.
- 46. The system of claim 41, the non-linear detector comprising a non-linear digital detector.
- 47. The system of claim 46, wherein the non-linear digital detector comprises CMOS detector elements and circuitry to extend dynamic range.

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48. The system of claim 46, wherein the non-linear digital detector comprises a digital circuit with different responses for different pixels.

49. The system of claim 46, wherein the non-linear digital detector comprises a digital circuit with detectors having logarithmic response.

EXAMINER'S COMMENT

New Claim 41 recites the limitations of previous Claim 9 (and parent Claim 1), which Examiner objected to in the Final office action as being allowable if placed in dependent form.

The reasons for allowance were previously asserted in the Final Office Action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to STEPHEN YAM whose telephone number is (571)272-2449. The examiner can normally be reached on Monday-Friday 8:30am-5pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Epps can be reached on (571)272-2328. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Stephen Yam/ Primary Examiner, Art Unit 2878